

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/656,301	LEE ET AL.		
Examiner	Art Unit		
ANH H. DO	2624		

SEARCHED					
Class	Subclass	Date	Examiner		
386	52, 55	6/20/2007	AD		
382	232,				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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(INCLUD	ING SEAR	CH STRATEG	Y)
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